

# **Sustainable advanced manufacturing via machine learning-assisted exploitation of sensing and data infrastructure**

**Transforming Foundation Industries Network+ Conference**

**Iñaki Esnaola, George Panoutsos, John Provis, Xiuzhen Ye, and Scott Notley**

**Department of Automatic Control and Systems Engineering**

**University of Sheffield**

**Bal Kalirai and Russell Field**

**Robinson Brothers Limited**

**December 5, 2023**

# Project Overview

## Aims and Objectives

### Aim of the Collaboration

- **Aim:** To develop integral data acquisition and analytics frameworks that leverage expert process knowledge with ML techniques. This will yield informed data infrastructure design guidelines that **will accelerate the uptake of ML in the manufacturing process.**

### Technical Challenges

#### 1. Development of Quantitative Framework

- Industrial processes governed by complex multi-stage physical systems that rely on sequential decision making
- Current ML activity not focused on this type of processes: **data scarcity**
- Define new metrics that capture the performance specifications in a framework that is compatible with ML techniques

#### 2. Optimal Process Monitoring and Feature Identification

- **Information density** estimation to characterise evidence provided by parameter to yield performance
- Identification of **optimal parameters and sampling times** to maximise utility of monitoring data
- Characterisation of parameter ranges that result in high yield
- Novel **data acquisition infrastructure guidelines** to upgrade industrial plants for efficient operation

#### 3. Prediction of Manufacturing process performance

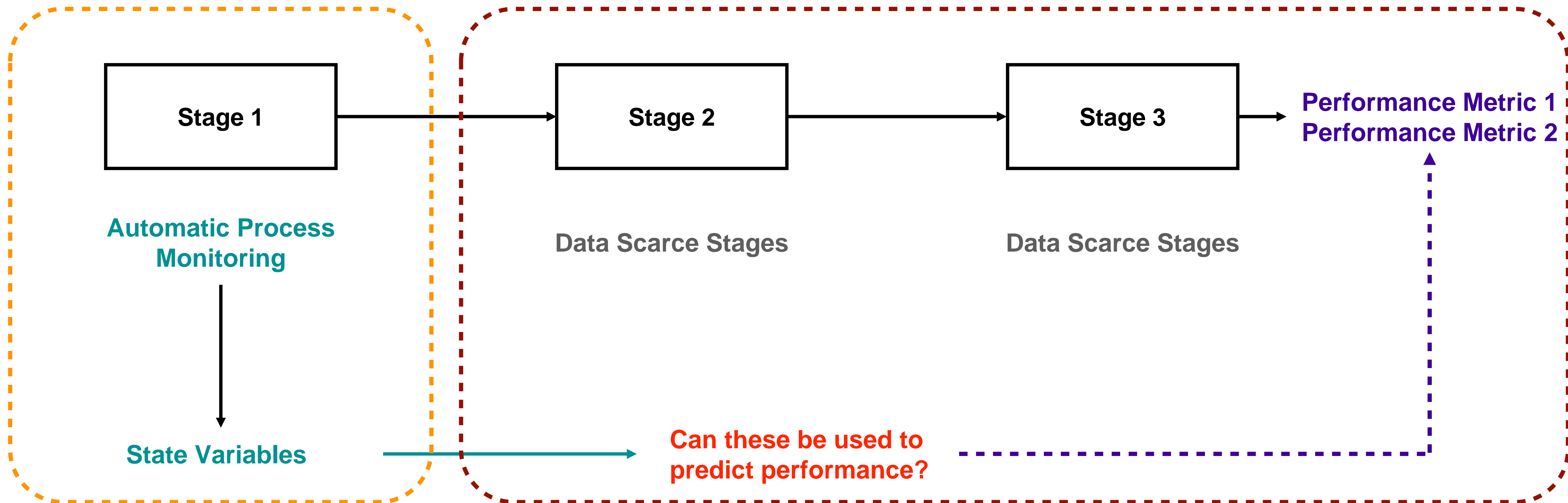
- ML capability poses demands sensing and data acquisition infrastructure
- Effectiveness of the data capability analysis and ML implementation methodology

# Optimal Process Monitoring and Feature Identification

## Project Outcomes

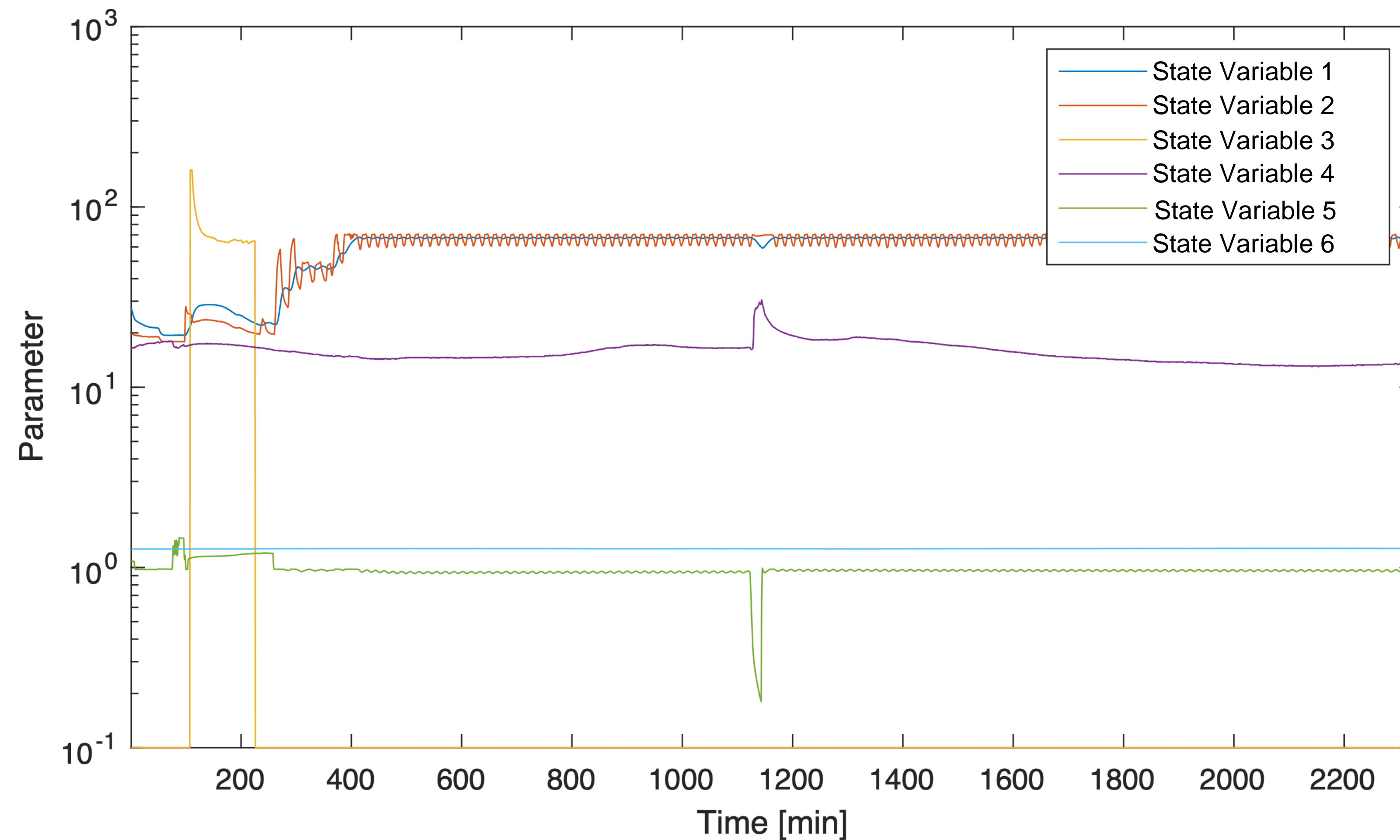
Data-Rich Environment

Data-Scarce Environment



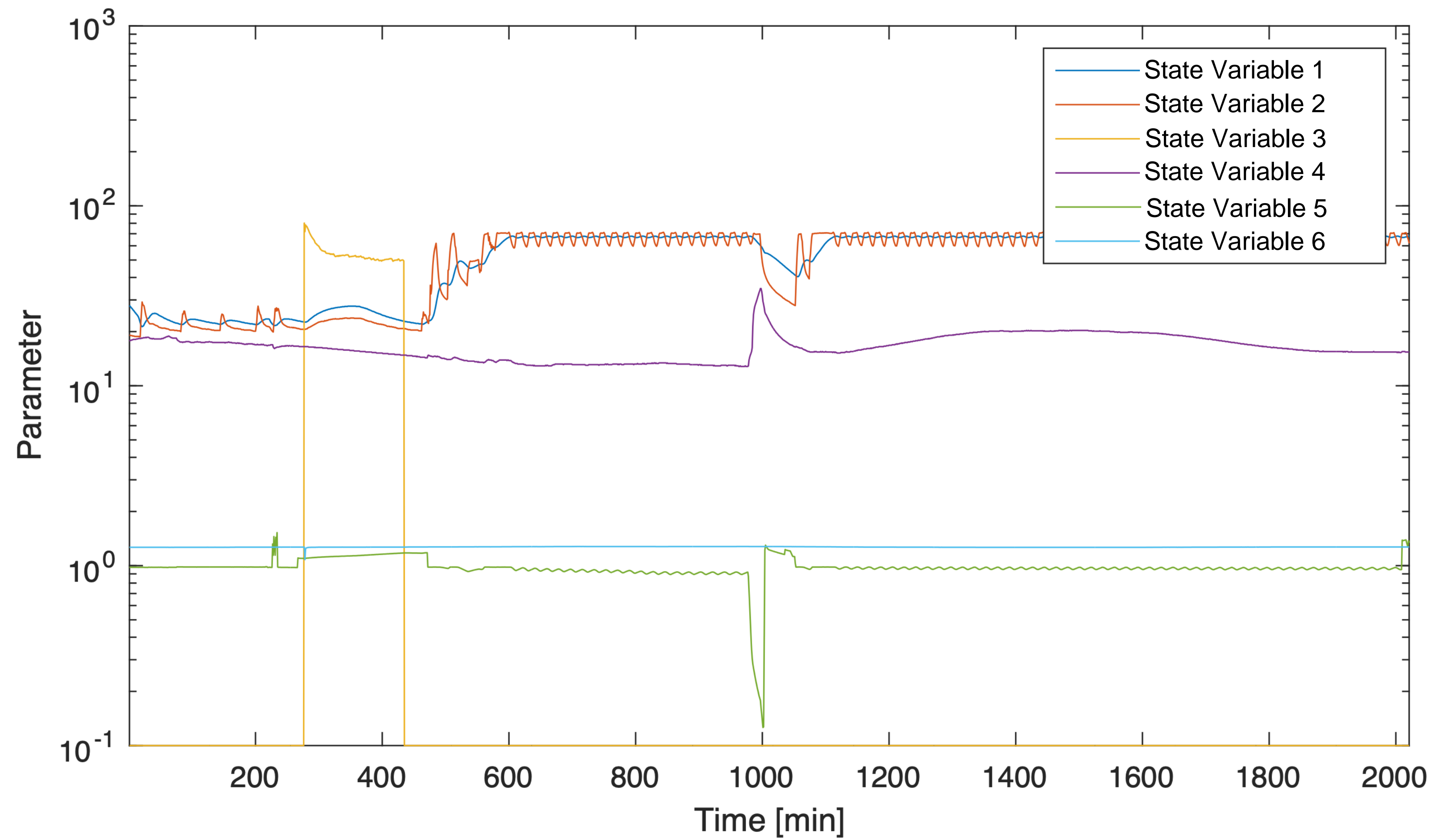
# Optimal Process Monitoring and Feature Identification

Example of batch 1



# Optimal Process Monitoring and Feature Identification

Example of batch 2



# Optimal Process Monitoring and Feature Identification

## Parameter Feature Identification Approaches

### What are the parameter features that *best* describe the process performance?

#### • Approach 1: Relying on visual inspection of to describe features

- Finding features that can be geometrically described in terms of the time-series characteristics.
- Performance is poor, identification relies on **human pattern recognition**: humans require in general more data samples to overcome bias.
- Solution is **not scalable**: visualisation in high-dimensional settings is challenging.
- Solution is **not systematic**: extending it to a different process or data source is not straightforward.

#### • Approach 2: Mathematical definition of features describing the process parameter time-series

- The time-series contain ~2000 samples per batch: cannot be used in as features in raw format.
- Classical statistical features provided poor performance.
- Ad-hoc human pattern recognition did not provide desired performance.

#### • Approach 3: Information-Theoretic definition of features

- We use information measures to **quantify the amount of evidence** provided by the time-series at each time instant.
- The proposed features can be **ranked** according to the value they provide for yield/ash estimation.
- **Operational insight** from time-series
  - Dynamical *value of data* assessment.
  - Parameter data storage assessment.

# Optimal Process Monitoring and Feature Identification

## Mutual Information

### Stochastic Model

- Parameter we wish to estimate:  $X \sim \mathbb{P}_X$
- Time-series available to perform estimation:  $\left\{ (Y_i^{(1)}, Y_i^{(2)}, Y_i^{(3)}, Y_i^{(4)}, Y_i^{(5)}, Y_i^{(6)}) \right\}_{i=1}^n \sim \mathbb{P}_Y$
- Joint probability distribution:  $\left\{ X, (Y_i^{(1)}, Y_i^{(2)}, Y_i^{(3)}, Y_i^{(4)}, Y_i^{(5)}, Y_i^{(6)}) \right\}_{i=1}^n \sim \mathbb{P}_{XY}$

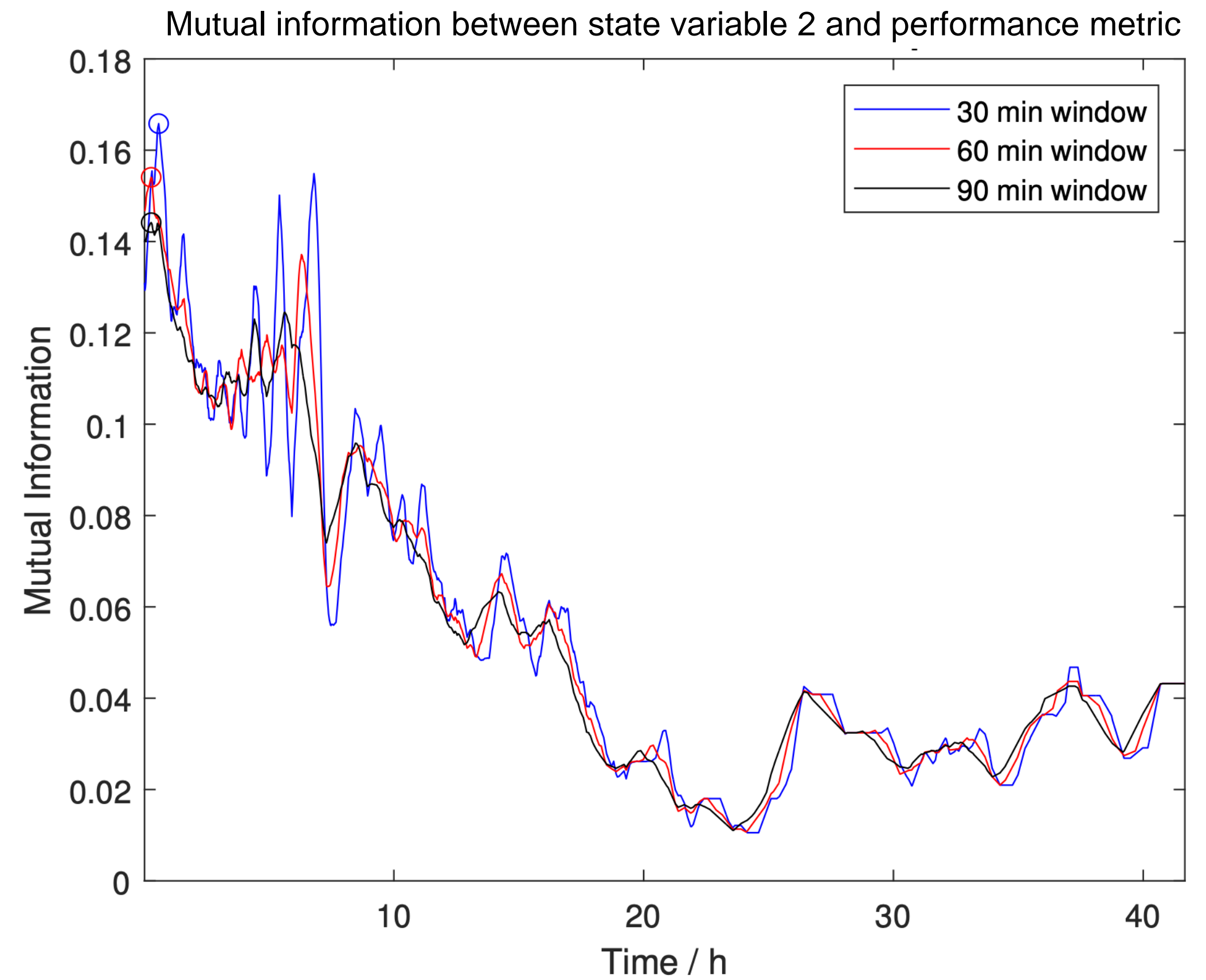
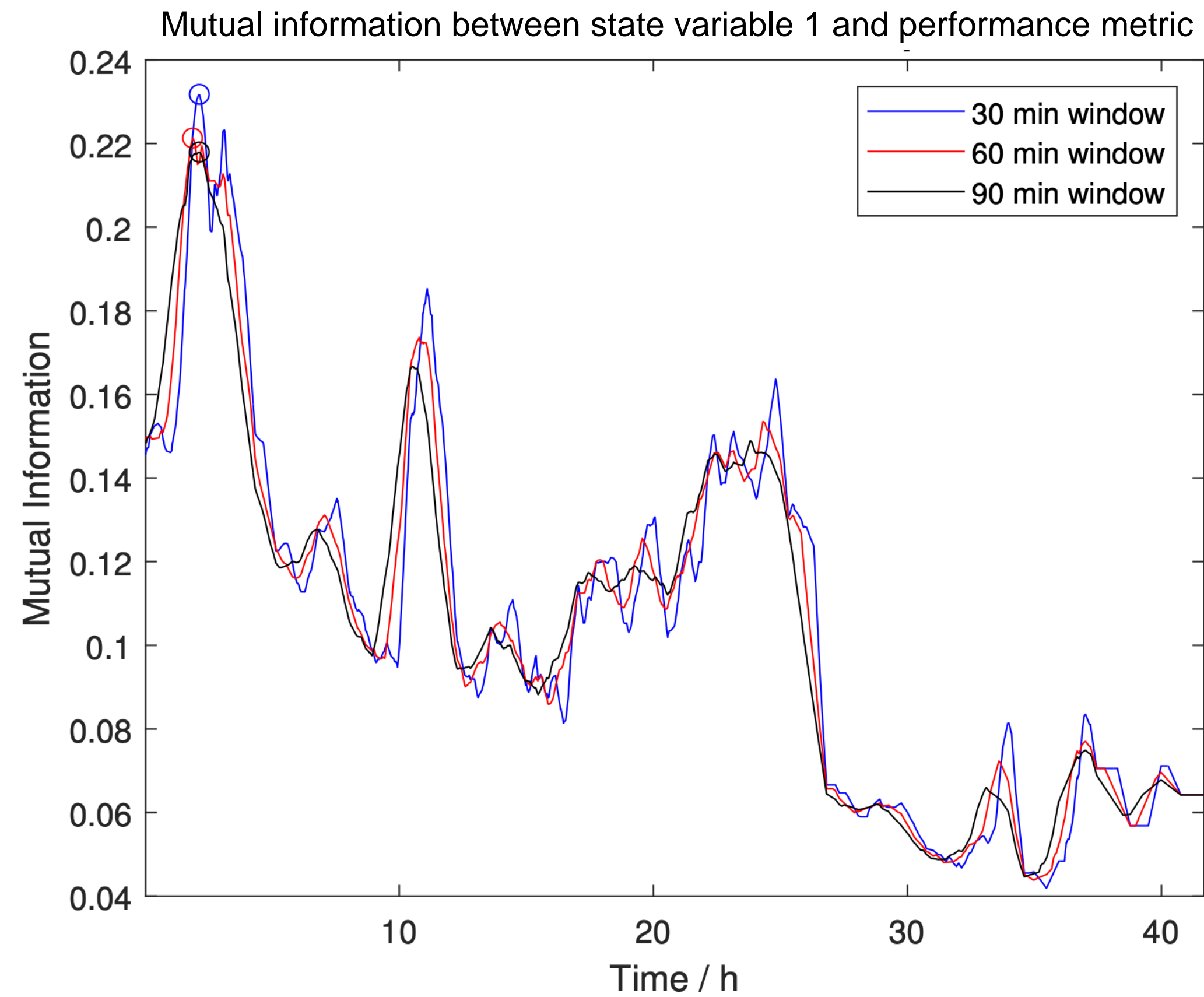
### Information Density

- We compute the **mutual information** at each time instant to evaluate the evidence provided by the parameter  $k$  data at each time instant:

$$\text{Information}(Y_i^{(k)} \rightarrow X) = \int \log \left( \frac{d\mathbb{P}_{Y_i^{(k)} X}}{d\mathbb{P}_{Y_i^{(k)}} \mathbb{P}_X} \left( X, Y_i^{(k)} \right) \right) d\mathbb{P}_{Y_i^{(k)} X}$$

# Numerical Evaluation of Mutual Information

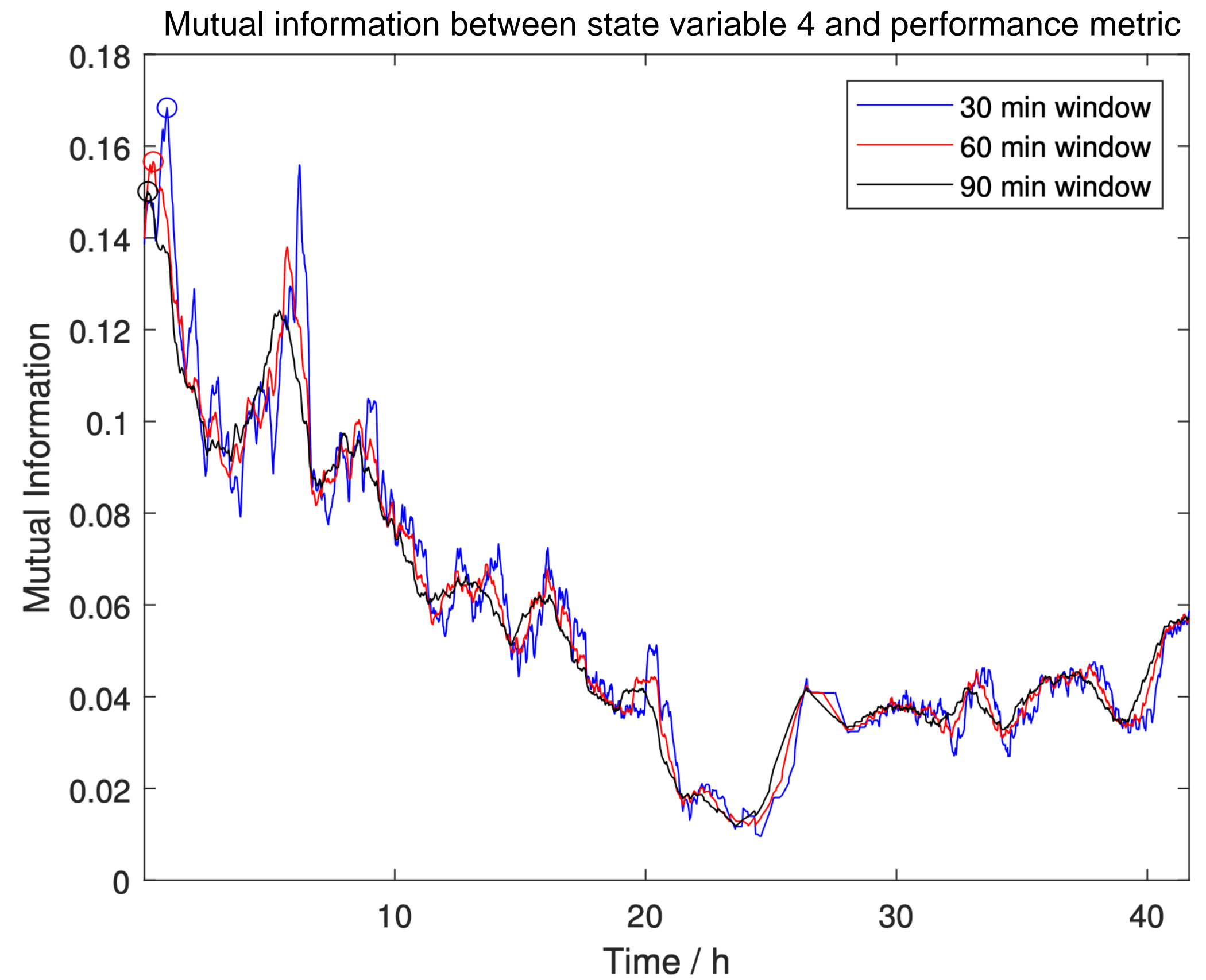
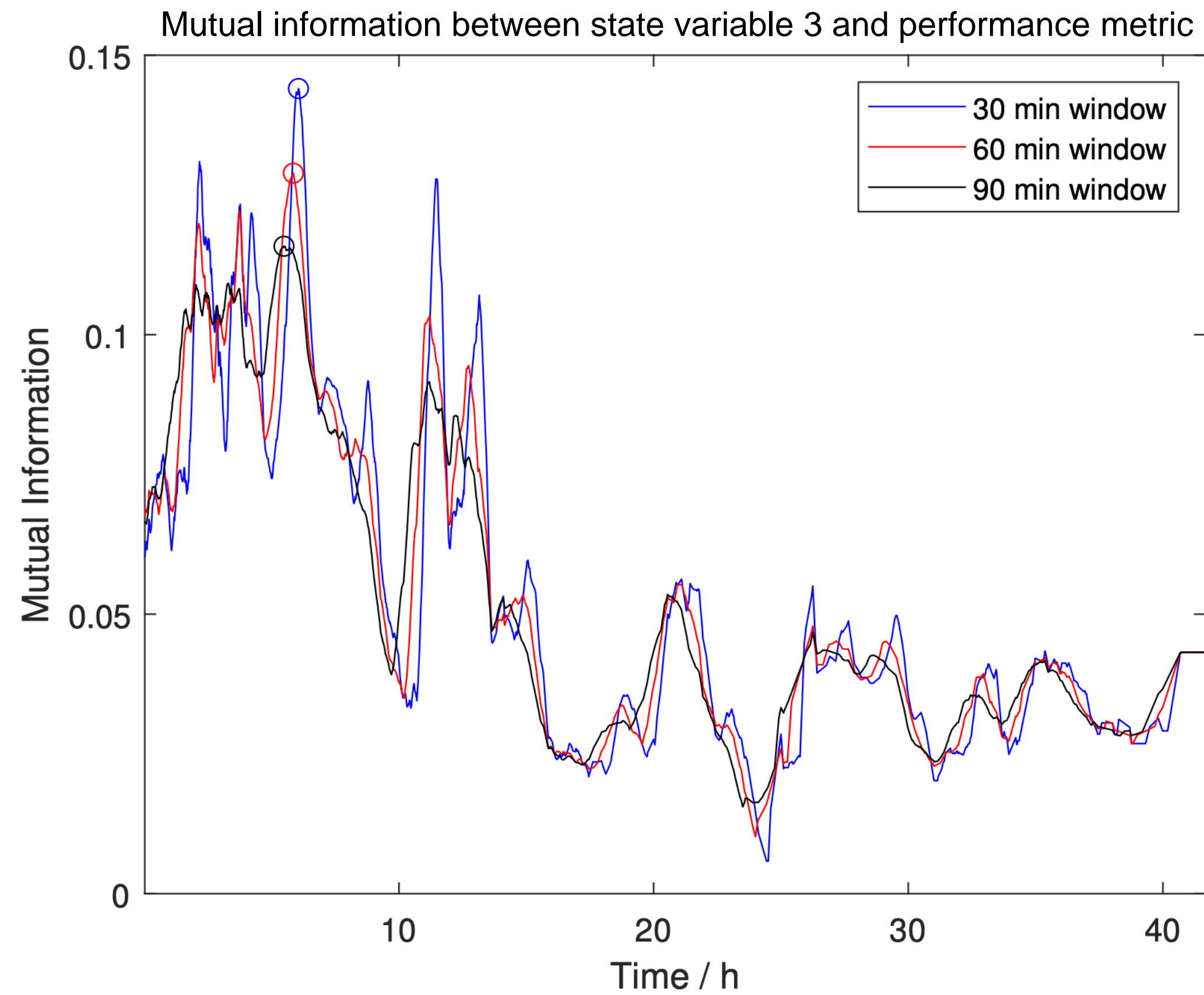
## Analysis of Performance Metric 1





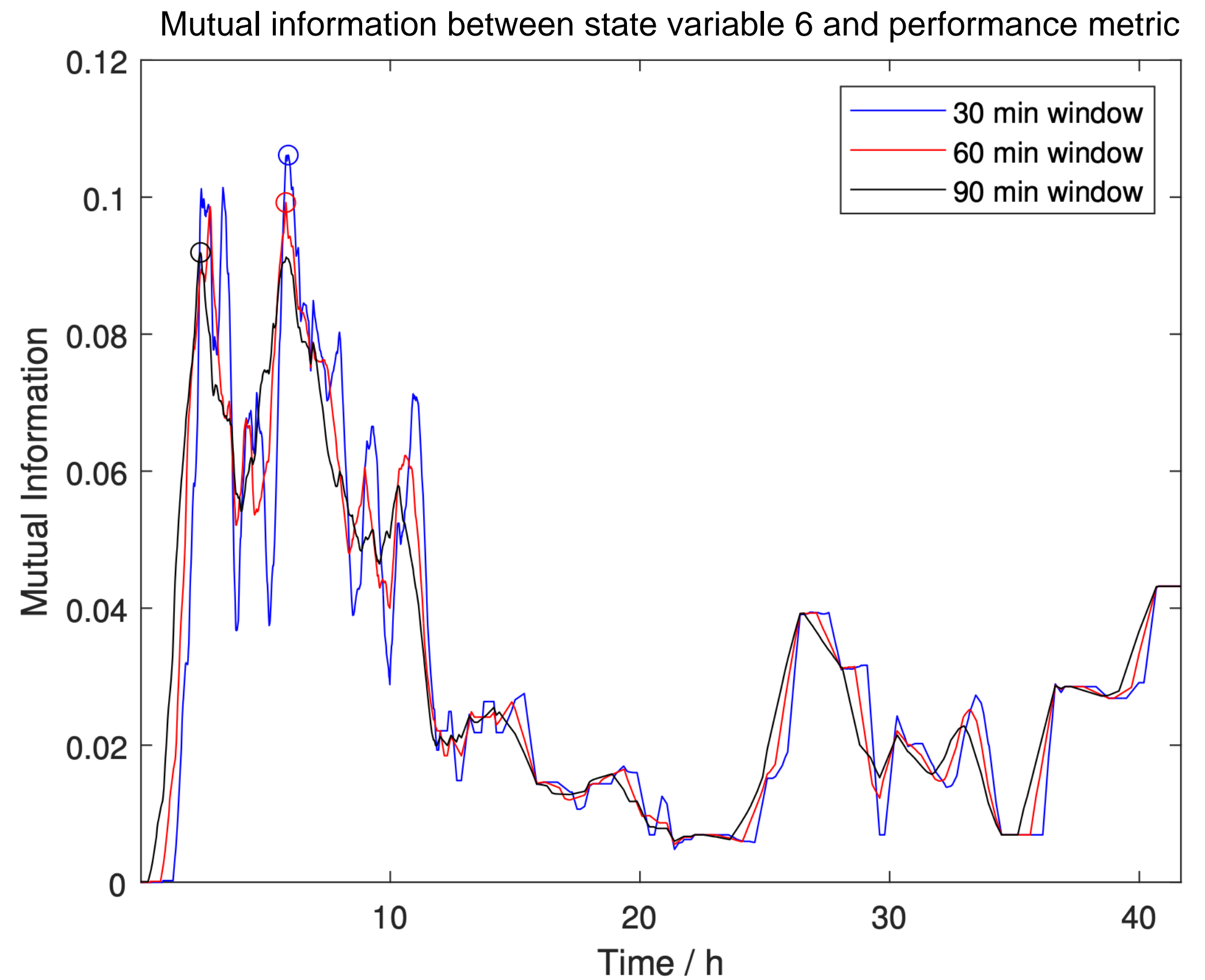
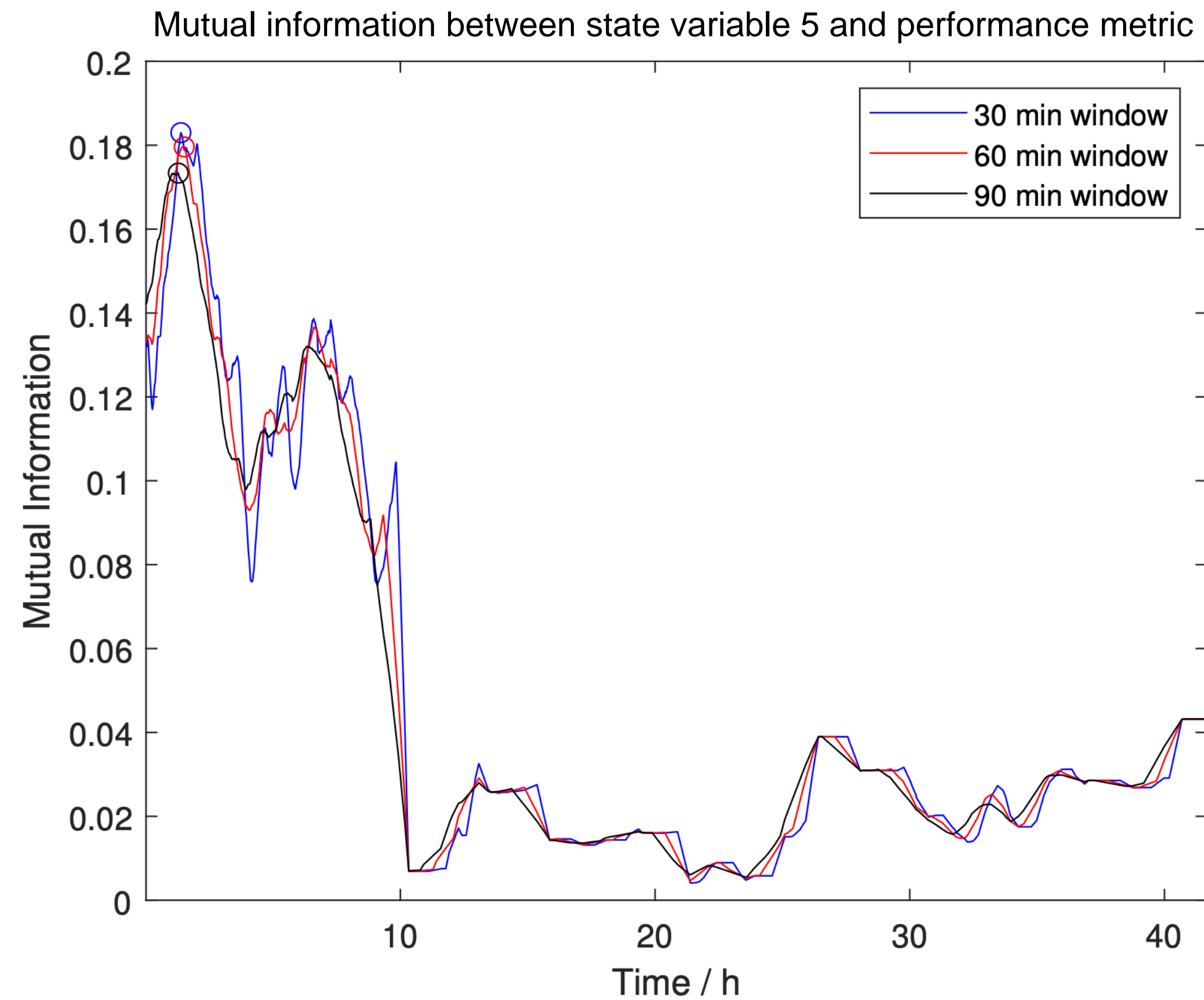
# Numerical Evaluation of Mutual Information

## Analysis of Performance Metric 1



# Numerical Evaluation of Mutual Information

## Analysis of Performance Metric 1



# Numerical Evaluation of Mutual Information

Optimal Parameter (5 min Window) Range Identification for **Performance Below 5% Percentile**

Parameter	Sampling Time	Range	Probability of Poor Performance
State Variable 1	188	[20, 30]	0.13
State Variable 2	392	[23, 27] and [47, 53]	0.14 and 0.17
State Variable 3	422	[25, 30] and [45, 50]	0.17 and 0.25
State Variable 4	227	[1.0, 1.1]	0.19
State Variable 5	<b>98</b>	[1.24, 1.26]	0.15
State Variable 6	167	0.1 and [100, 120]	<b>0.29 and 1</b>

# Numerical Evaluation of Mutual Information

Optimal Parameter (30 min Window) Range Identification for **Performance Below 5% Percentile**

Parameter	Sampling Time	Range	Probability of Poor Performance
State Variable 1	128	[20, 30]	0.13
State Variable 2	83	[1.24, 1.26]	0.16
State Variable 3	55	[23, 26]	0.22
State Variable 4	<b>35</b>	[25, 29]	<b>0.25</b>
State Variable 5	363	[0.95, 1.15]	0.08
State Variable 6	355	[0, 75]	0.07

# Numerical Evaluation of Mutual Information

Optimal Parameter (5 min Window) Joint Range Identification for **Performance Below 5% Percentile**

Parameter	Sampling Time	Range	Probability of Poor Performance
State Variable 1	<b>59</b>	[22, 28]	<b>0.44</b>
State Variable 2		[23, 26]	
State Variable 3		[25, 28]	

Parameter	Sampling Time	Range	Probability of Poor Performance
State Variable 1	<b>145</b>	[20, 30]	<b>0.57</b>
State Variable 2		[22, 24.5]	
State Variable 3		[23, 26]	
State Variable 4		[0.9, 1] and [1.2, 1.5]	
State Variable 5		[1.243, 1.263]	
State Variable 6		0.1	

# Prediction of Yield/Ash

## Regression Analysis

### Bayesian Estimation Methods

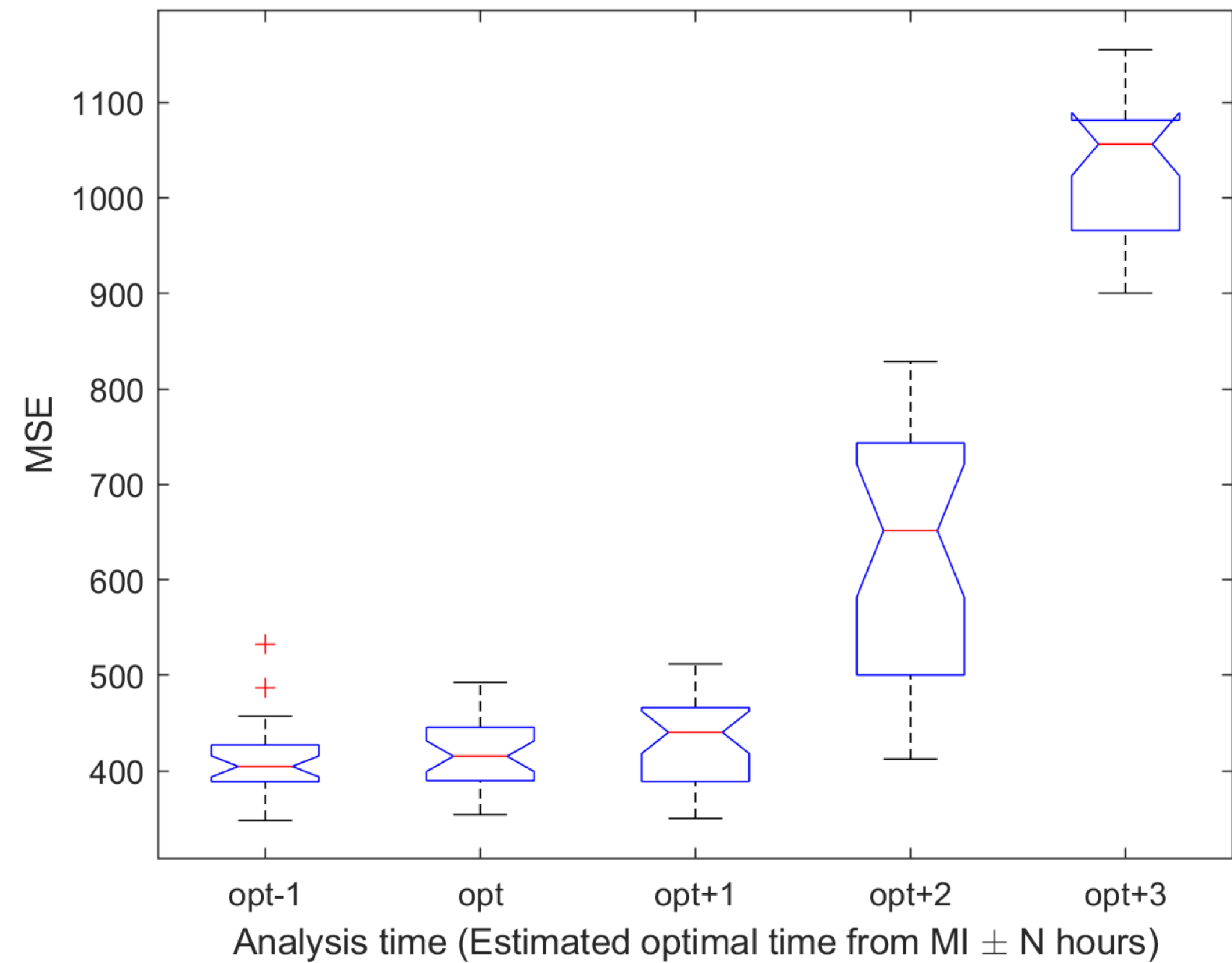
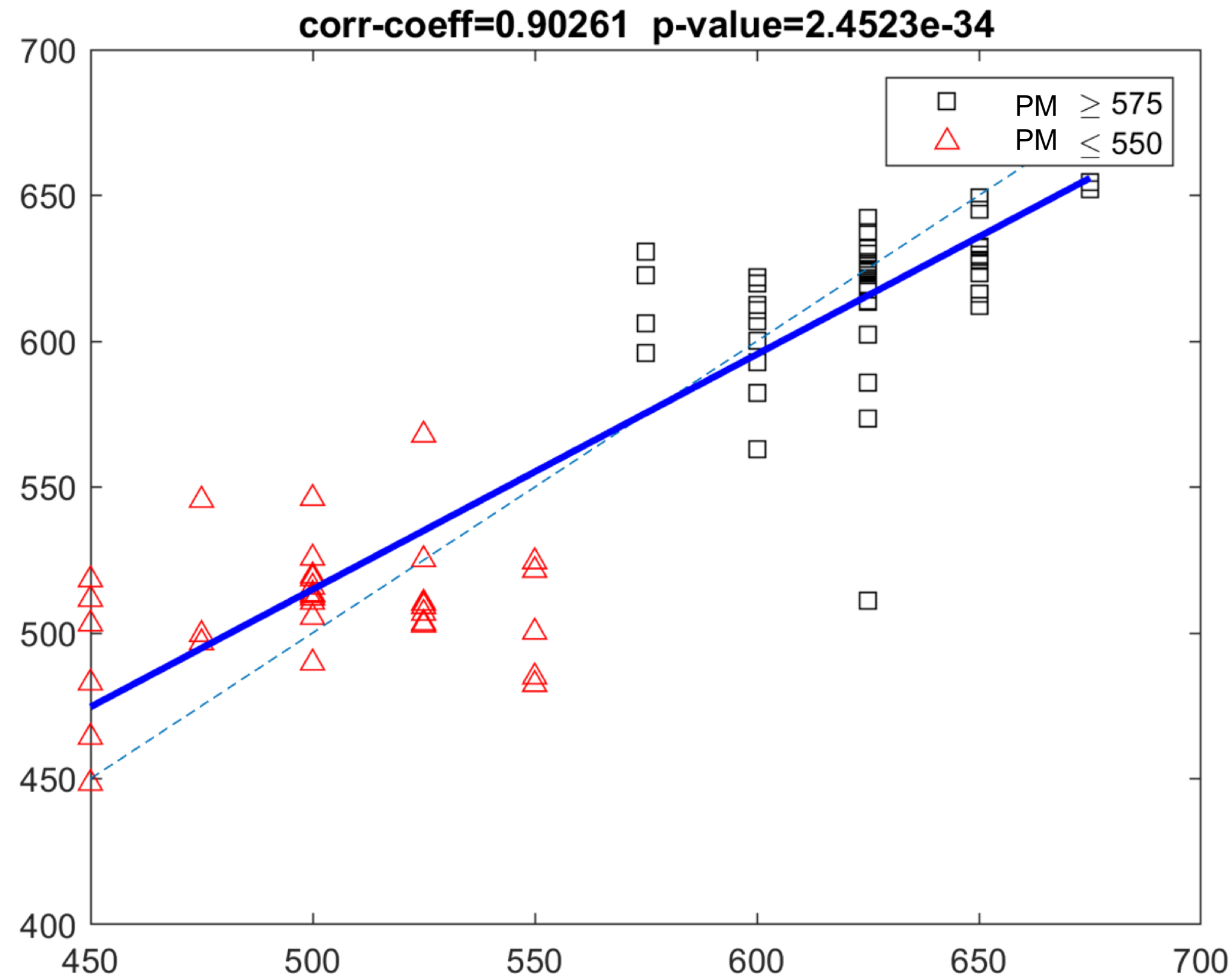
- We studied the feasibility of **Minimum Mean Square Error (MMSE)** estimators: not feasible at this stage due to lack of training data.
  - Second order statistics are required for time-series.
  - Mismatch introduced by **data scarcity** and **dynamics** of the time-series is too large.
  - Worth revisiting if there is more data available: **Kalman Filter** to exploit dynamical nature of data.

### Neural Network based Regression

- Neural networks are **universal approximators**.
- Efficient learning paradigm that achieves good performance in several learning tasks.
- We cannot input the raw time-series to the neural network due to the lack of sufficient data.
- Current regression **error is moderate** but our simulations rely on synthetically generated data.
- **Our data sampling method improves performance with respect to visually selected features.**
  - Future exploitation of the data will benefit from mutual information based sampling.
  - More data required to characterize validity of neural networks for high-precision tasks.
- We plan to carry out uncertainty analysis to understand the effect of dynamics; possibly across multiple process stages.

# Prediction of Performance Metric Forecasting

## Numerical Results



# Information Measures based Regularization to Overcome Data Scarcity

S.M. Perlaza, G. Bisson, I. Esnaola, A. Jean-Marie, and S. Rini, "Empirical Risk Minimization With Relative Entropy Regularization: Optimality and Sensitivity Analysis," in Proc. IEEE International Symposium on Information Theory, Helsinki, Finland, Jul. 2022

## Problem Formulation: ERM with Relative Entropy Regularization (ERM-RER)

The ERM-RER problem, with parameters  $Q \in \Delta(\mathcal{M}, \mathcal{B}(\mathcal{M}))$  and  $\lambda \in (0, +\infty)$ , consists of the optimization over the domain  $\Delta_Q(\mathcal{M}, \mathcal{F}) \triangleq \{P \in \Delta(\mathcal{M}, \mathcal{F}) : P \ll Q\}$  given by

$$\min_{P \in \Delta_Q(\mathcal{M}, \mathcal{B}(\mathcal{M}))} R_z(P) + \lambda D(P \| Q).$$

## Theorem

For all  $\lambda \in \mathcal{K}_{Q,z}$ , the solution to the ERM-RER problem, denoted by  $P_{\Theta|Z=z}^{(Q,\lambda)} \in \Delta_Q(\mathcal{M}, \mathcal{B}(\mathcal{M}))$ , is a **unique** measure whose Radon-Nikodym derivative with respect to  $Q$  satisfies for all  $\theta \in \text{supp}(Q)$ ,

$$\frac{dP_{\Theta|Z=z}^{(Q,\lambda)}}{dQ}(\theta) = \exp\left(-K_{Q,z}\left(-\frac{1}{\lambda}\right) - \frac{1}{\lambda}L_z(\theta)\right).$$



# Conclusions

## 1. Information Measures enable definition of a Quantitative Framework

- Information measures are **operationally meaningful** metrics
- Provide data acquisition system **design guidelines: optimal parameters and sampling times**
  - Simpler **digital infrastructure**
  - Sense only the informative data: **less sensors**
  - Save only the necessary data: **less data storage**

## 2. Feature Identification in Dynamic Multi-Stage Settings with Data Scarcity

- Systematic characterisation of relevant features
- Clustering and classification based on information density
- Fundamental limits describe best achievable performance

## 3. Novel information based regularization to leverage expert knowledge and first principles

- Mitigate data scarcity
- Provide explainability and robustness guarantees for ML tools

**Thanks!**

`esnaola@sheffield.ac.uk`